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**Bipolar Monolithic Front-end Preamplifier for use with
Silicon Photodetectors**

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Second Workshop on electronics for LHC experiments in Balaton

Swg713

3.1 Peaking time

Measured transient pulse responses on 50Ω load are shown in figure 4 for input capacitance $C_{in}=100\text{pF}$, $R_f=20\text{K}\Omega$, $C_f=0.5\text{pF}$ and with four collector current (I_c) values for the input bipolar transistor. The current gain is dominated by $[C_{in}/I_c].KT/q$ terms.

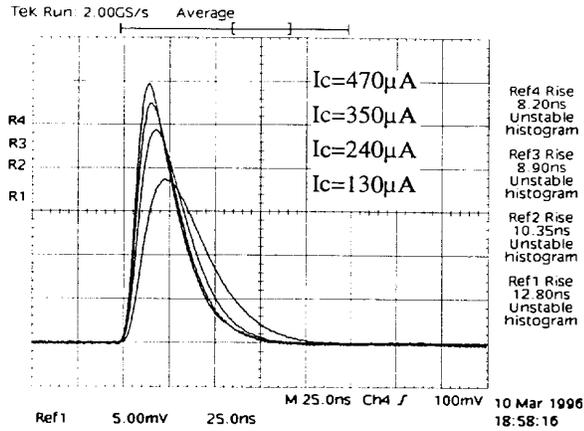


figure 4: output pulse waveform

Charges collection is very fast. In fact the shaping time observed is given by electronic response. After this, a comparison between electrical charges injection and the gamma source ^{55}Fe has been realized. Charge pulse is produced by step voltage generator. The rise time is 2ns and equivalent charge equal to 4.10^6e^- .

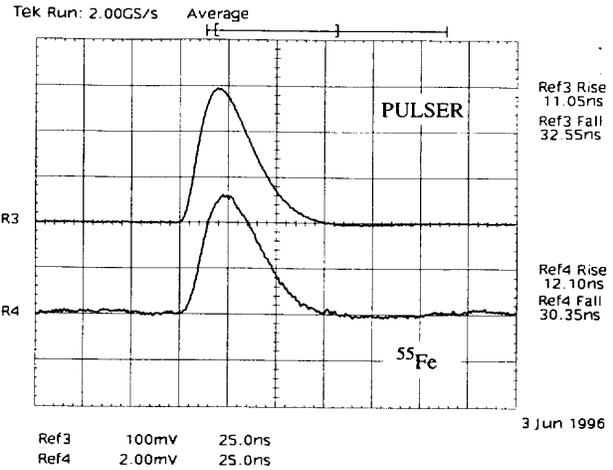


figure 6: pulser and γ source responses

3.2 Response time

The responses of the different charge injection have been measured with Hamamatsu APD S5345 ($C_d=90\text{pF}$). At 320V bias voltage the gain is approximately 50. A collector current of $300\mu\text{A}$ is used for the NPN input transistor of preamplifier. It is a good compromise with respect to speed and noise. First the APD is exposed to a nitrogen laser pulse. Typical light pulse width is 3ns and wavelength equal to 337.1nm. Figure 5 shows the response of APD associated to SLCC32 preamplifier on 50Ω load.

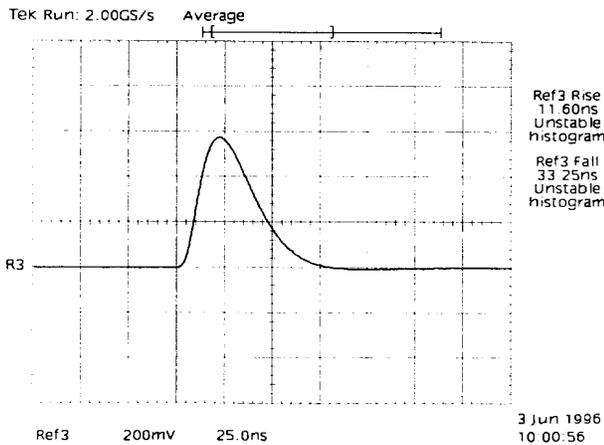


figure 5: light pulse response

These responses are very similar. It is a typical feature of whole photodetector system.

3.3 Noise measurement

The noise has been measured after RC shaping amplifier (integration = 50ns) according to collector current for 2 input capacitance values. The calibration has been done with ^{57}Co source and PIN photodetector. The r.m.s. voltmeter and digital oscilloscope has been used. Results are shown in figure 7

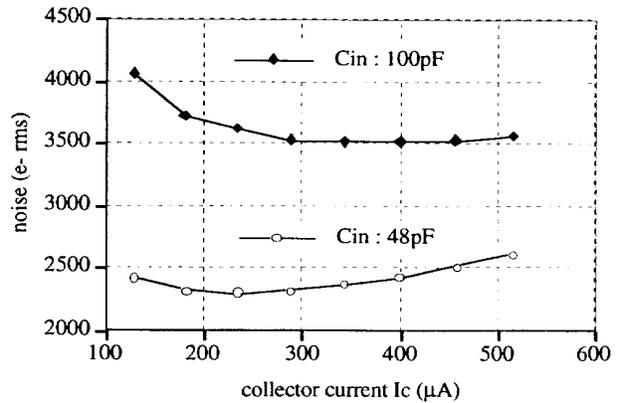


figure 7

These curves show clearly the relative contributions of serial and parallel noise. The choice of collector current fixes the noise and the response time.

4. RADIATION HARDNESS TESTS

Three prototypes SLCC32 preamplifiers have been irradiated at Ulysse reactor at Saclay [5] up to 10^{12} fast neutrons/cm² under bias conditions.

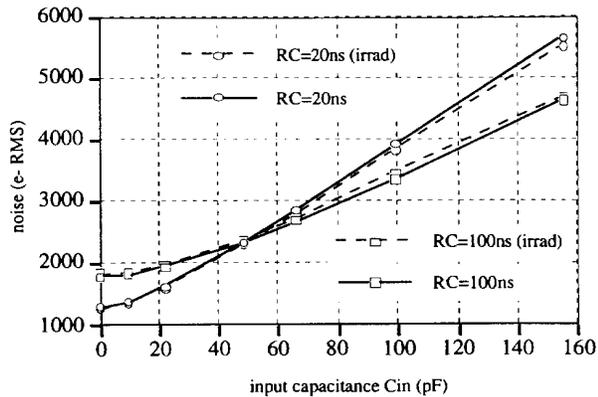


figure 8: noise measurement

At this dose, no significant noise increase has been observed for 20ns and 100ns integration shaping time. More studies are needed to check the radiation hardness at upper dose.

5. CONCLUSION

These additional measurements on version1 confirm the feasibility of front-end electronics in UHF-1 bipolar transistor technology in fast and low noise applications. Version 2 is under development with the following characteristics:

- reduce the input transistor base spreading resistance down to values below 50Ω ,
- large range gain adaptation,
- DC coupling capability with leakage current control,
- 3 independent functions: preamp, buffer, DCamp,
- total power consumption $\leq 20\text{mW}$.

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